

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination FORSTADIUS ET AL.	
		Examiner Andrew C Lee	Art Unit 2664	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-6,763,231 B2	07-2004	Takatori et al.	455/420
B	US-6,717,516 B2	04-2004	Bridgelall, Raj	340/572.1
C	US-6,775,258 B1	08-2004	van Valkenburg et al.	370/338
D	US-6,490,687 B1	12-2002	Nagai, Hiroto	713/202
E	US-5,473,667	12-1995	Neustein, Simon	340/7.29
F	US-6,452,910 B1	09-2002	Vij et al.	370/310
G	US-5,224,150	06-1993	Neustein, Simon	340/7.44
H	US-5,973,613	10-1999	Reis et al.	340/7.23
I	US-6,195,006 B1	02-2001	Bowers et al.	340/572.1
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	
V	
W	
X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.